

## **AOD452**

# **N-Channel Enhancement Mode Field Effect Transistor**

### **General Description**

The AOD452 uses advanced trench technology and design to provide excellent  $R_{\text{DS(ON)}}$  with low gate charge. This device is suitable for use in PWM, load switching and general purpose applications.

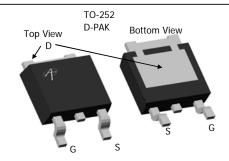
## **Features**

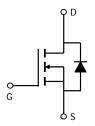
 $V_{DS}(V) = 25V$  $I_{D} = 55 \text{ A (V}_{GS} = 10V)$ 

 $R_{DS(ON)}$  < 8.5 m $\Omega$  (V<sub>GS</sub> = 10V)  $R_{DS(ON)}$  < 14 m $\Omega$  (V<sub>GS</sub> = 4.5V)

100% UIS tested 100%  $R_g$  tested







Absolute Maximum Ratings T <sub>A</sub> =25°C unless otherwise noted							
Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		$V_{DS}$	25	V			
Gate-Source Voltage		$V_{GS}$	±20	V			
Continuous Drain	T <sub>C</sub> =25°C		55				
Current <sup>G</sup>	T <sub>C</sub> =100°C	I <sub>D</sub>	43				
Pulsed Drain Current C		I <sub>DM</sub>	150	A			
Pulsed Forward Diode Current <sup>C</sup>		I <sub>SM</sub>	150				
Avalanche Current <sup>C</sup>		I <sub>AR</sub>	35				
Repetitive avalanche energy L=0.1mH <sup>C</sup>		E <sub>AR</sub>	61	mJ			
	T <sub>C</sub> =25°C	P <sub>D</sub>	51.5	W			
Power Dissipation <sup>B</sup>	T <sub>C</sub> =100°C	- FD	25.5	VV			
	T <sub>A</sub> =25°C	D	2.5	W			
Power Dissipation A	T <sub>A</sub> =70°C	-P <sub>DSM</sub>	1.6	VV			
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 175	°C			

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	i 10s R <sub>θJA</sub>		20	°C/W			
Maximum Junction-to-Ambient A	Steady-State		39	50	°C/W			
Maximum Junction-to-Case <sup>B</sup>	Steady-State	$R_{\theta JC}$	2.4	2.9	°C/W			
Maximum Junction-to-TAB B	Steady-State	$R_{\theta JC\text{-TAB}}$	2.7	3.2	°C/W			

#### Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Тур	Max	Units	
STATIC F	PARAMETERS						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =250uA, V <sub>GS</sub> =0V	25			V	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =20V, V <sub>GS</sub> =0V			1	μΑ	
		T <sub>J</sub> =55°C			5		
I <sub>GSS</sub>	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ =±20V			100	nA	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$	1.2	1.8	3	V	
$I_{D(ON)}$	On state drain current	$V_{GS}$ =10V, $V_{DS}$ =5V				Α	
R <sub>DS(ON)</sub>		$V_{GS}$ =10V, $I_D$ =30A		6.5	8.5	mo	
	Static Drain-Source On-Resistance	T <sub>J</sub> =125°C		9.7	12	mΩ	
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A		11.5	14	mΩ	
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =10A		35		S	
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A, V <sub>GS</sub> =0V		0.72	1	V	
I <sub>S</sub>	Maximum Body-Diode Continuous Curr	ntinuous Current			55	Α	
DYNAMIC	PARAMETERS						
C <sub>iss</sub>	Input Capacitance			1230	1476	pF	
Coss	Output Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =12.5V, f=1MHz		315	400	pF	
C <sub>rss</sub>	Reverse Transfer Capacitance			190	280	pF	
$R_g$	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz		1.2	2	Ω	
SWITCHI	NG PARAMETERS	•					
Q <sub>g</sub> (10V)	Total Gate Charge			26.4	32	nC	
Q <sub>g</sub> (4.5V)	Total Gate Charge			13.5	17	nC	
$Q_{gs}$	Gate Source Charge	$V_{GS}$ =10V, $V_{DS}$ =12.5V, $I_{D}$ =20A		3.9	5	nC	
$Q_{gs(Vth)}$	Gate Source Charge at Vth			1.3	2	nC	
$Q_{gd}$	Gate Drain Charge			7.8	10	nC	
t <sub>D(on)</sub>	Turn-On DelayTime			6.5	8	ns	
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =12.5V, $R_L$ =0.6 $\Omega$ ,		10	20	ns	
$t_{D(off)}$	Turn-Off DelayTime	$R_{GEN}$ =3 $\Omega$		22.7	30	ns	
t <sub>f</sub>	Turn-Off Fall Time			6.2	12	ns	
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =20A, dI/dt=100A/μs		23.1	28	ns	
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	<sub>e</sub> I <sub>F</sub> =20A, dl/dt=100A/μs		15.3	18	nC	

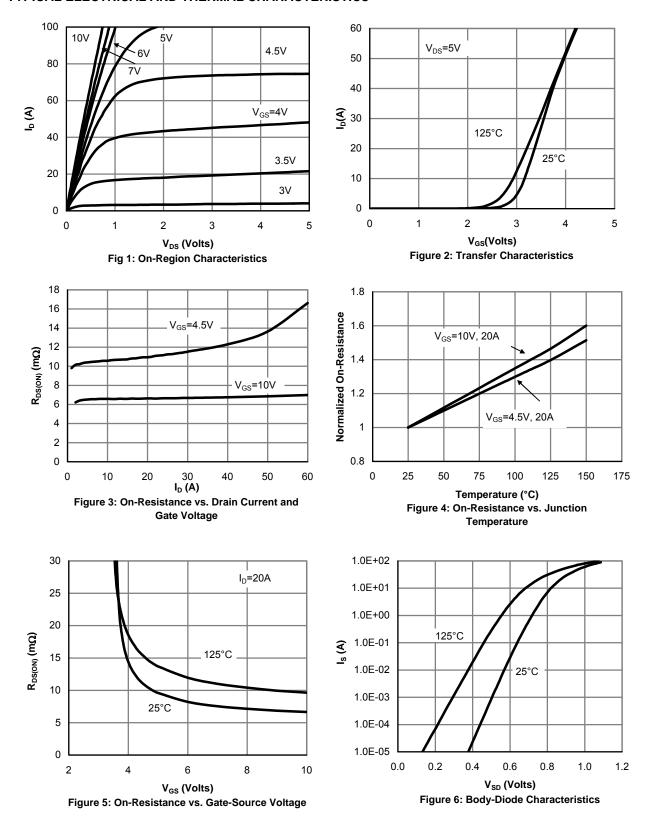
A: The value of R  $_{0JA}$  is measured with the device mounted on 1in  $^2$  FR-4 board with 2oz. Copper, in a still air environment with T  $_A$  =25°C. The Power dissipation P  $_{DSM}$  is based on R  $_{0JA}$  and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

- B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- C: Repetitive rating, pulse width limited by junction temperature T  $_{J(MAX)}$ =175°C.
- D. The R  $_{\theta JA}$  is the sum of the thermal impedence from junction to case R  $_{\theta JC}$  and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300  $\,\mu s$  pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T  $_{J(MAX)}$ =175°C.
- G. The maximum current rating is limited by bond-wires.
- H. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T <sub>A</sub>=25°C. The SOA curve provides a single pulse rating.

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#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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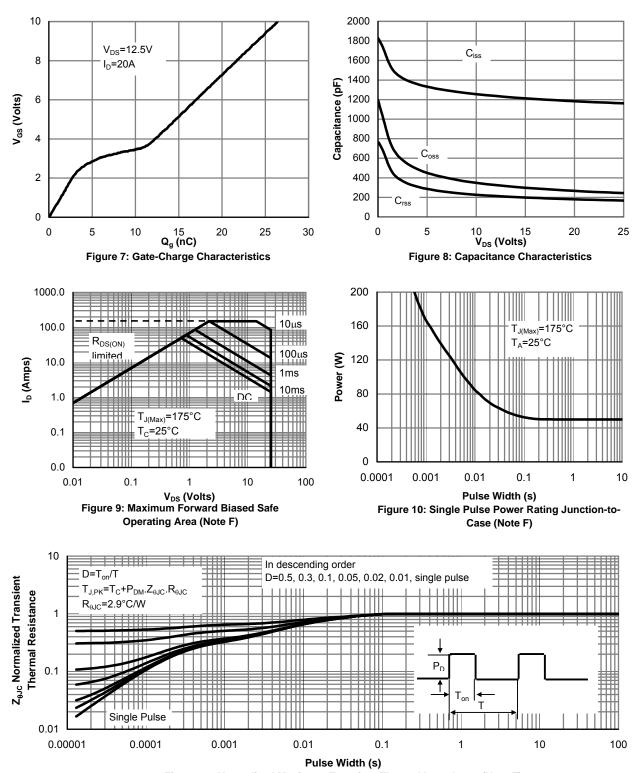


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

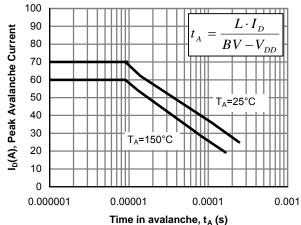


Figure 12: Single Pulse Avalanche capability

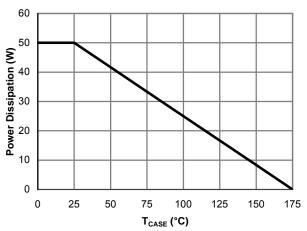


Figure 13: Power De-rating (Note B)

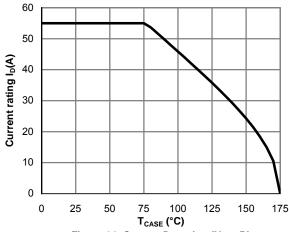


Figure 14: Current De-rating (Note B)

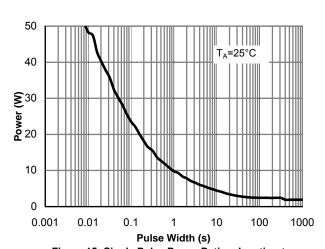


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

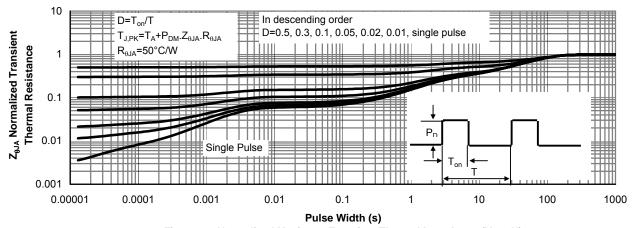


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)